Applicant(s)/Patent Under Application/Control No. Reexamination 10/736,336 KIM ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2832 Anh T. Mai **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 336/200 US-6,759,937 07-2004 Kyriazidou, Chryssoula Α US-В US-С US-D ·Ε US-US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 11219825 A 08-1999 WAKAMATSU et al. Japan Ν O Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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